

<b>Notice of References Cited</b>	Application/Control No. 10/786,072		Applicant(s)/Patent Under Reexamination ISHII ET AL.	
	Examiner Patrick A. Darno		Art Unit 2163	Page 1 of 1

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*	C	US-5,260,551	11-1993	Wiik et al.	340/5.28
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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